

April 1988 Revised August 1999

74F545

Octal Bidirectional Transceiver with 3-STATE Outputs

General Description

The 74F545 is an 8-bit, 3-STATE, high-speed transceiver. It provides bidirectional drive for bus-oriented microprocessor and digital communications systems. Straight through bidirectional transceivers are featured, with 24 mA bus drive capability on the A Ports and 64 mA bus drive capability on the B Ports.

One input, Transmit/Receive (T/\overline{R}) determines the direction of logic signals through the bidirectional transceiver. Transmit enables data from A-to-B Ports; Receive enables data from B-to-A Ports. The Output Enable input disables both A and B Ports by placing them in a 3-STATE condition.

Features

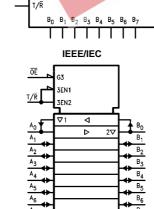
- Higher drive than 8304
- 8-bit bidirectional data flow reduces system package
- 3-STATE inputs/outputs for interfacing with bus-oriented systems
- 24 mA and 64 mA bus drive capability on A and B Ports, respectively
- Transmit/Receive and Output Enable simplify control logic
- Guaranteed 4000V minimum ESD protection

Ordering Code:

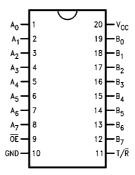
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Order Number	Package Number	Package Description
74F545SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
74F545PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbols



Connection Diagram



Unit Loading/Fan Out

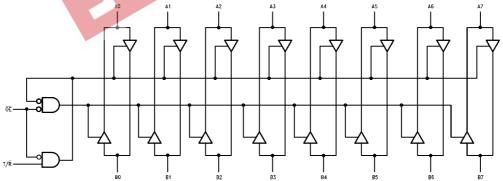
Pin Names	Description	U.L.	Input I _{IH} /I _{IL}		
Pin Names	Description	HIGH/LOW	Output I _{OH} /I _{OL}		
ŌĒ	Output Enable Input (Active LOW)	1.0/2.0	20 μA/–1.2 mA		
T/R	Transmit/Receive Input	1.0/2.0	20 μA/–1.2 mA		
A ₀ -A ₇	Side A 3-STATE Inputs or	3.5/1.083	70 μΑ/–650 μΑ		
	3-STATE Outputs	150/40 (33.3)	–3 mA/24 mA (20 mA)		
B ₀ –B ₇	Side B 3-STATE Inputs or	3.5/1.083	70 μΑ/–650 μΑ		
	3-STATE Outputs	600/106.6 (80)	-12 mA/64 mA (48 mA)		

Truth Table

Inp	uts	Outputs			
ŌĒ	T/R	3 /1			
L	L	Bus B Data to Bus A			
L	Н	Bus A Data to Bus B			
Н	Х	High Z			

- H = HIGH Voltage Level L = LOW Voltage Level X = Immaterial Z = High Impedance

Logic Diagram



Absolute Maximum Ratings(Note 1)

-65°C to +150°C

-0.5V to +5.5V

Input Voltage (Note 2) -0.5V to +7.0V
Input Current (Note 2) -30 mA to +5.0 mA

Voltage Applied to Output

Storage Temperature

in HIGH State (with $\rm V_{CC} = 0V)$ Standard Output $\rm -0.5V$ to $\rm V_{CC}$

3-STATE Output
Current Applied to Output

in LOW State (Max) twice the rated I_{OL} (mA) ESD Last Passing Voltage (Min) 4000V

Recommended Operating Conditions

Free Air Ambient Temperature $0^{\circ}\text{C} \text{ to } +70^{\circ}\text{C}$ Supply Voltage +4.5V to +5.5V

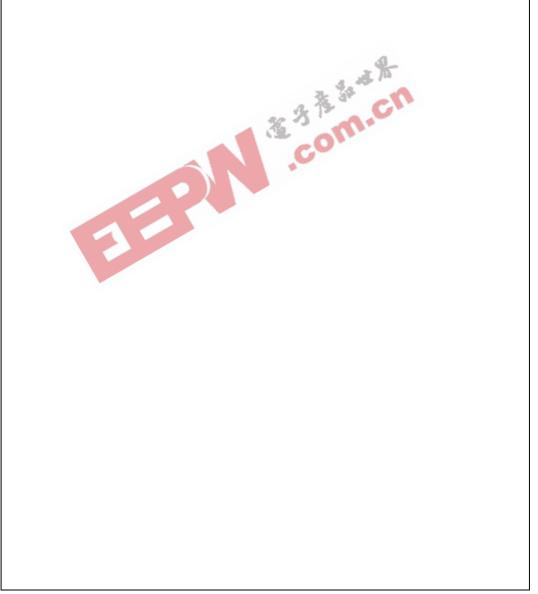
Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

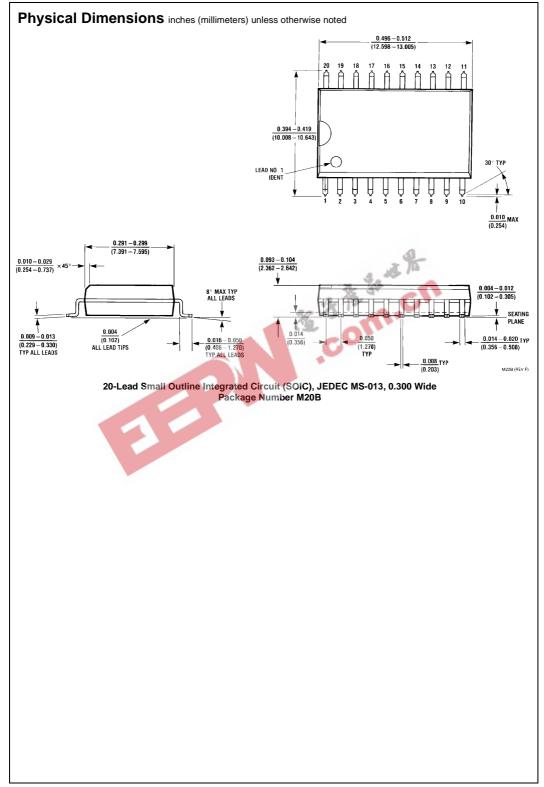
Note 2: Either voltage limit or current limit is sufficient to protect inputs.

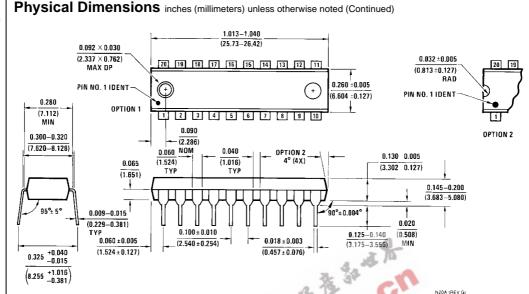
DC Electrical Characteristics

Symbol	Parameter		Min	Тур	Max	Units	Vcc	Conditions
V _{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal
V _{IL}	Input LOW Voltage				0.8	V		Recognized as a LOW Signal
V _{CD}	Input Clamp Diode Voltage				-1.2	V	Min	I _{IN} = -18 mA (OE, T/R)
V _{OH}	Output HIGH 10%	√ V _{CC}	2.5		CIL		-	$I_{OH} = -1 \text{ mA } (A_n)$
	Voltage 10%	6 V _{CC}	2.4		-	O.		$I_{OH} = -3 \text{ mA } (A_n)$
	10%	6 V _{CC}	2.0			V	Min	$I_{OH} = -15 \text{ mA } (B_n)$
	5%	% V _{CC}	2.7					$I_{OH} = -1 \text{ mA } (A_n)$
	5%	% V _{CC}	2.7					$I_{OH} = -3 \text{ mA } (A_n)$
V _{OL}	Output LOW 10%	6 V _{CC}			0.5	V	Min	$I_{OL} = 24 \text{ mA } (A_n)$
	Voltage 10%	% V _{CC}			0.55	V	IVIIN	$I_{OL} = 64 \text{ mA } (B_n)$
I _{IH}	Input HIGH				5.0		Max	V _{IN} = 2.7V (OE , T/ R)
	Current				5.0	μА	iviax	V _{IN} = 2.7 V (OE, 1/R)
I _{BVI}	Input HIGH Current				7.0		Max	V _{IN} = 7.0V (OE , T/ R)
	Breakdown Test				7.0	μА	iviax	V _{IN} = 7.0V (OE, 1/R)
I _{BVIT}	Input HIGH Current				0.5	mA	Max	$V_{IN} = 5.5V (A_n, B_n)$
	Breakdown (I/O)				0.5	IIIA	IVIAX	$V_{IN} = 5.5V (A_n, D_n)$
I _{CEX}	Output HIGH				50	μА	Max	V _{OUT} = V _{CC}
	Leakage Current				30	μА	IVIAX	VOUT = VCC
V_{ID}	Input Leakage		4.75			V	0.0	$I_{ID} = 1.9 \mu\text{A}$
	Test		4.73			v	0.0	All Other Pins Grounded
I _{OD}	Output Leakage				3.75	μА	0.0	V _{IOD} = 150 mV
	Circuit Current				5.75	μΑ	0.0	All Other Pins Grounded
I _{IL}	Input LOW Current				-1.2	mA	Max	$V_{IN} = 0.5V (\overline{OE}, T/\overline{R})$
I _{IH} + I _{OZH}	Output Leakage Current				70	μА	Max	$V_{OUT} = 2.7V (A_n, B_n)$
I _{IL} + I _{OZL}	Output Leakage Current				-650	μΑ	Max	$V_{OUT} = 0.5V (A_n, B_n)$
los	Output Short-Circuit Current		-60		-150	A	Max	$V_{OUT} = 0V(A_n)$
			-100		-225	mA	iviax	$V_{OUT} = 0V (B_n)$
I _{ZZ}	Bus Drainage Test				500	μА	0.0V	V _{OUT} = 5.25V
I _{CCH}	Power Supply Current			70	90	mA	Max	V _O = HIGH
I _{CCL}	Power Supply Current			95	120	mA	Max	$V_O = LOW$
I _{CCZ}	Power Supply Current			85	110	mA	Max	V _O = HIGH Z

AC E	lectrical Characte	ristics							
	Parameter		$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			$T_{A} = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$		$T_A = 0$ °C to $+70$ °C $V_{CC} = +5.0V$ $C_L = 50$ pF	
Symbol									
		Min	Тур	Max	Min	Max	Min	Max	
t _{PLH}	Propagation Delay	2.5	4.2	6.0	2.0	7.5	2.5	7.0	ns
t _{PHL}	A_n to B_n or B_n to A_n	2.5	4.6	6.0	2.0	7.5	2.5	7.0	115
t _{PZH}	Output Enable Time	3.0	5.3	7.0	2.5	9.0	3.0	8.0	
t _{PZL}		3.5	6.0	8.0	3.0	10.0	3.5	9.0	ns
t _{PHZ}	Output Disable Time	3.0	5.0	6.5	2.5	9.0	3.0	7.5	115
t _{PI 7}		2.0	5.0	6.5	2.0	10.0	2.0	7.5	







20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N20A

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